Radio Astronomy, Lecture 3

Dr Alexey Potapov

Max Planck Institute for Astronomy Laboratory Astrophysics Group

Laboratory Astrophysics









IRAM FILM



<u>Today VL3 30.10.</u>

Signal processing

Receiver Noise

Bolometer

Heterodyne Receiver

Wiener-Khinchin Theorem



Fig. 4.1 A sketch of the relation between the voltage input as a function of time, V(t), and frequency, V(v), with the autocorrelation function, ACF, $R(\tau)$, and corresponding power spectral density, PSD, S(v). The two-headed arrows represent reversible processes

$$R(\tau) = \int_{-\infty}^{\infty} S(\mathbf{v}) e^{2\pi i \mathbf{v} \tau} d\mathbf{v}$$













Filters:

Band pass filter, $V_{min} < V < V_{max}$

Band stop filter, $v_{min} < v < v_{max}$ eliminated

Low pass filter, $v < v_{max}$

High pass filter, $v > v_{max}$

All pass filter, phase change





Noise

 0;0
 TMC-1C
 COH2
 30MED-UO-FO 0:09-MAY-2015
 R:30-NOV-2015

 RA:
 04:41:16.10
 DEC:
 25:49:43.8
 Eq
 2000.0
 Offs:
 +0.0
 +0.0

 Unknown
 tau:
 0.074
 Tsys:
 100.
 Time:
 1.36E+03min
 EI:
 0.0

 N:
 51
 I0:
 -23682.6
 V0:
 6.000
 Dv:
 -0.5639
 LSR

 F0:
 103850.000
 Df:
 0.1953
 Fi:
 91348.7575

</tabular



Noise

 O;0
 TMC-1C
 COH2
 30ME0-UO-F0 0:09-MAY-2015
 R:30-NOV-2015

 RA:
 04:41:16.10
 DEC:
 25:49:43.8
 Eq
 2000.0
 Offs:
 +0.0
 +0.0

 Unknown
 tau:
 0.074
 Tsys:
 100.
 Time:
 1.36E+03min
 EI:
 0.0

 N:
 51
 I0:
 -23682.6
 V0:
 6.000
 Dv:
 -0.5639
 LSR

 F0:
 103850.000
 Df:
 0.1953
 Fi:
 91348.7575

</tabular







Receiver T_{rec} and system T_{sys} noise temperatures at the LO frequency of 804 GHz: 1) T_{rec} 2) T_{sys} including the emission cell without windows 3) T_{sys} including the evacuated cell and HDPE windows 4) T_{sys} including the evacuated cell and Teflon windows 5) T_{sys} including the cell and Teflon windows, the cell is filled with 1 bar of air

Radiometer formula:

$$\frac{\Delta T}{T_{\rm sys}} = \frac{1}{\sqrt{\Delta v \,\tau}}$$

Receiver stability

$$\frac{\Delta T_{\rm RMS}}{T_{\rm R}} = \frac{\Delta G}{G}$$

 ΔT - root mean square (RMS) noise, Δv - bandwidth, τ - integration time, G - gain

Bolometer

Energy balance equation:



Capacity (C = $\Delta Q/\Delta T$) Conductance (G = 1/*R*) Power absorbed





Cooled down to K





Local oscillator (LO)



Mixer





Mixer $I = \alpha \left[E \sin(2\pi v_{\rm S} t + \delta_{\rm S}) + V \sin(2\pi v_{\rm LO} t + \delta_{\rm LO}) \right]^2$ Signal LO $I = \frac{1}{2}\alpha \left(E^2 + V^2\right)$ (DC component) $-\frac{1}{2}\alpha E^2 \sin(4\pi v_{\rm S}t + 2\delta_{\rm S} + \frac{\pi}{2})$ (2nd harmonic of signal) $-\frac{1}{2}\alpha V^2 \sin(4\pi v_{\rm LO}t + 2\delta_{\rm LO} + \frac{\pi}{2}) \qquad (2\text{nd harmonic of LO})$ $+\alpha VE \sin[2\pi(v_{\rm S}-v_{\rm LO})t + (\delta_{\rm S}-\delta_{\rm LO}+\frac{\pi}{2})]$ (difference frequency) $-\alpha VE \sin[2\pi(v_{\rm S}+v_{\rm LO})t+(\delta_{\rm S}+\delta_{\rm LO}+\frac{\pi}{2})]$ (sum frequency).

SIS (superconducting-insulating-supercondacting) Mixer



Fig. 2.2: Basic concept of a SIS-junction. **a)** Two superconductive electrodes (\approx 100 nm thickness) are divided by a thin insulating barrier (\approx 2-5 nm thickness).





Hot electron bolometer (HEB) Mixer





Fig. 1.10: Left: Microscope picture of a 1.9 THz waveguide cavity and substrate channel carrying a silicon nitride membrane with an HEB mixer and integrated waveguide circuit.

Side band problem



$$f(LO) - f$$
 or $f - f(LO)$
LSB USB
 -2 -1 LO +1 +2 GHz

USB: f = f(LO) + f(IF)f(IF) = f - f(LO)

LSB: f = f(LO) - f(IF)f(IF) = f(LO) - f

Side band problem



Fig. 5.6 A sketch of the single sideband mixer (SSB). The input signal, f(t), is divided into two equal parts. There are two identical mixers located in an *upper* and *lower* branch of the sketch. The LO frequency from a central source, ω_c , is shifted in phase by $\pi/2$ from the input to the output of the mixer in the *lower part* of the sketch. In the *lower* branch, the phase of the input signal is also shifted by $\pi/2$. After mixing the signals are added to produce the single sideband output

Amplifier, High Electron Mobility Transistor (HEMT)



Fig. 5.8 This figure shows a HEMT amplifier. As with FETs, the current flow from Source to Drain, around the Gate. The electric field from the Gate is shown as a darker, irregular region, has a large effect on the current flow from Source to Drain. Thus, this amplifies the signal placed on the Gate. Because of the potentials in the interface layers, the electrons can flow from Source to Drain only in a very thin layer. This is shown enclosed in semicircles; this part of the HEMT provides the gain. The quantity g_m is the transconductance, and u_{gs} is the velocity from gate to source. The product of these is the gain of the amplifier. The quantities labelled "L_s, L_D, etc." represent inductances internal to the HEMT; the "R"s are internal resistances, and "C"s are internal capacitances



Beauty in Radio Astronomy

24

0

4

222222

-

148 COACCECCC.

1

NASA

1 N747NA